

N-Channel Shielded Gate PowerTrench[®] MOSFET 150 V, 2.3 A, 144 m Ω

Features

- Shielded Gate MOSFET Technology
- Max $r_{DS(on)}$ = 144 m Ω at V_{GS} = 10 V, I_D = 2.3 A
- Max $r_{DS(on)}$ = 188 m Ω at V_{GS} = 6 V, I_D = 1.9 A
- High performance trench technology for extremely low r_{DS(on)}
- High power and current handling capability in a widely used surface mount package

S

Pin 1

SuperSOT[™] -6

n

D

- Fast switching speed
- 100% UIL Tested
- RoHS Compliant

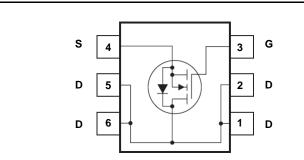


General Description

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench[®] process that incorporates Shielded Gate technology. This process has been optimized for $r_{DS(on)}$, switching performance and ruggedness.

Applications

- Load Switch
- Synchronous Rectifier
- Primary Switch



MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

Symbol	Parameter	Ratings	Units		
V _{DS}	Drain to Source Voltage		150	V	
V _{GS}	Gate to Source Voltage		±20	V	
1	Drain Current -Continuous	(Note 1a)	2.3	Α	
D	-Pulsed		10		
E _{AS}	Single Pulse Avalanche Energy	(Note 3)	12	mJ	
P _D	Power Dissipation	(Note 1a)	1.6		
	Power Dissipation	(Note 1b)	0.8		
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-55 to +150	°C	

Thermal Characteristics

$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case		30	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	78	C/W

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
.244	FDC86244	SSOT-6	7 "	8 mm	3000 units

FDC86244 N-Channel Shielded Gate PowerTrench[®] MOSFET

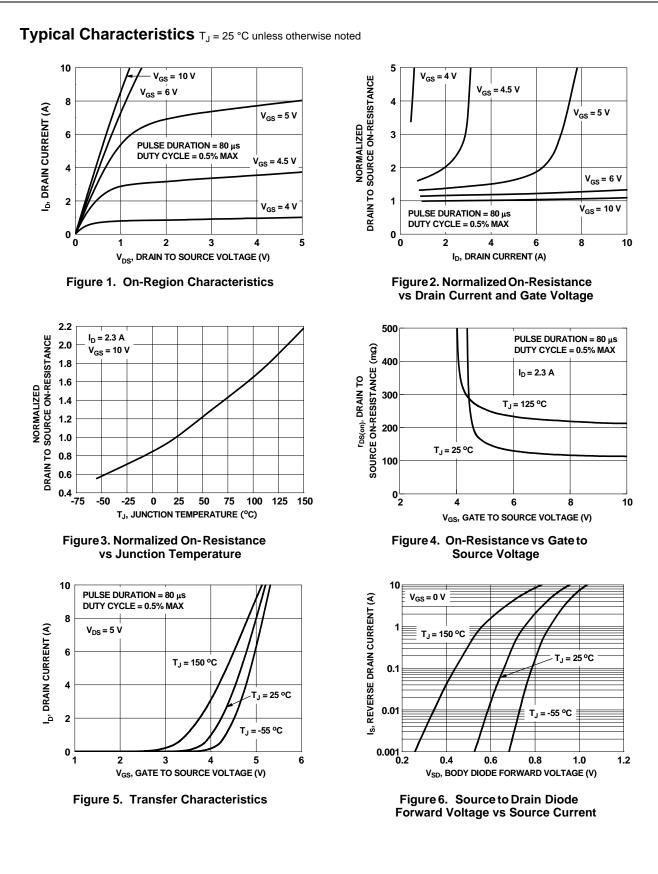
April 2015

$ \begin{array}{c} \Delta BV_{DSS} \\ \overline{\Delta T_J} \\ I_{DSS} \\ \overline{L_{SSS}} \\ $	istics in to Source Breakdown Voltage akdown Voltage Temperature officient o Gate Voltage Drain Current e to Source Leakage Current	$I_D = 250 \mu A, V_{GS} =$ $I_D = 250 \mu A, referentV_{DS} = 120 V, V_{GS} =$	nced to 25 °C	150	103		V mV/°C
$\begin{array}{c c} BV_{DSS} & Dra \\ \hline \Delta BV_{DSS} & Bre \\ \hline \Delta T_{J} & Coe \\ I_{DSS} & Zer \\ I_{GSS} & Gat \\ \end{array}$	in to Source Breakdown Voltage akdown Voltage Temperature efficient o Gate Voltage Drain Current	$I_{D} = 250 \ \mu A$, reference $V_{DS} = 120 \ V$, $V_{GS} = 120 \ V$, $V_{SS} = 120 $	nced to 25 °C	150	103		
$\begin{array}{c} \Delta BV_{DSS} \\ \overline{\Delta T_J} \\ D_{DSS} \\ \overline{I_{OSS}} \\ \overline{I_{GSS}} \\ \end{array} \begin{array}{c} \overline{Gat} \\ \overline{On \ Character} \\ V_{GS(th)} \\ \end{array}$	efficient o Gate Voltage Drain Current	$I_{D} = 250 \ \mu A$, reference $V_{DS} = 120 \ V$, $V_{GS} = 120 \ V$, $V_{SS} = 120 $	nced to 25 °C		103		mV/°C
I _{DSS} Zer I _{GSS} Gat On Character V _{GS(th)} Gat	-		0.14				
On Character V _{GS(th)} Gat	e to Source Leakage Current		: 0 V			1	μA
V _{GS(th)} Gat		$V_{GS} = \pm 20 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$				±100	nA
V _{GS(th)} Gat	istics						
	e to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \ \mu A$		2.0	2.5	4.0	V
00(0)	e to Source Threshold Voltage	$I_D = 250 \ \mu$ A, referenced to 25 °C			-9		mV/°C
5	•	V _{GS} = 10 V, I _D = 2.3 A			113	144	-
r _{DS(on)} Stat	tic Drain to Source On Resistance	$V_{GS} = 6 V, I_D = 1.9 A$			128	188	mΩ
- (-)		V _{GS} = 10 V, I _D = 2.		214	273		
g _{FS} For	ward Transconductance	$V_{DD} = 5 \text{ V}, I_D = 2.3 \text{ A}$			6		S
Dynamic Cha	racteristics						
-	It Capacitance				260	345	pF
	put Capacitance	V _{DS} = 75 V, V _{GS} = 0 V, f = 1 MHz			32	45	pF
	erse Transfer Capacitance				1.7	5	pF
	e Resistance				1.3		Ω
Switching Ch	aracteristics						
t _{d(on)} Tur	n-On Delay Time	V_{DD} = 75 V, I _D = 2.3 A, V _{GS} = 10 V, R _{GEN} = 6 Ω			4.7	10	ns
	e Time				1.4	10	ns
t _{d(off)} Tur	n-Off Delay Time				10	20	ns
1	Time				3.1	10	ns
	al Gate Charge	$V_{GS} = 0 V \text{ to } 10 V$	-		4.2	6	nC
1010	al Gate Charge	$V_{GS} = 0 V \text{ to } 5 V$			2.4	4	nC
9-	al Gate Charge	I _D = 2.3 A			1.0		nC
Q _{gd} Gat	e to Drain "Miller" Charge				1.0		nC
Drain-Source	Diode Characteristics						
V _{SD} Sou	rce to Drain Diode Forward Voltage	$V_{GS} = 0 V, I_{S} = 2.3 J$	A (Note 2)		0.8	1.3	V
11	verse Recovery Time	— I _F = 2.3 A, di/dt = 100 A/μs —			45	73	ns
Q _{rr} Rev	verse Recovery Charge				33	53	nC

3. Starting T_J = 25 °C, L = 1.0 mH, I_{AS} = 5.0 A, V_{DD} = 135 V, V_{GS} = 10 V.

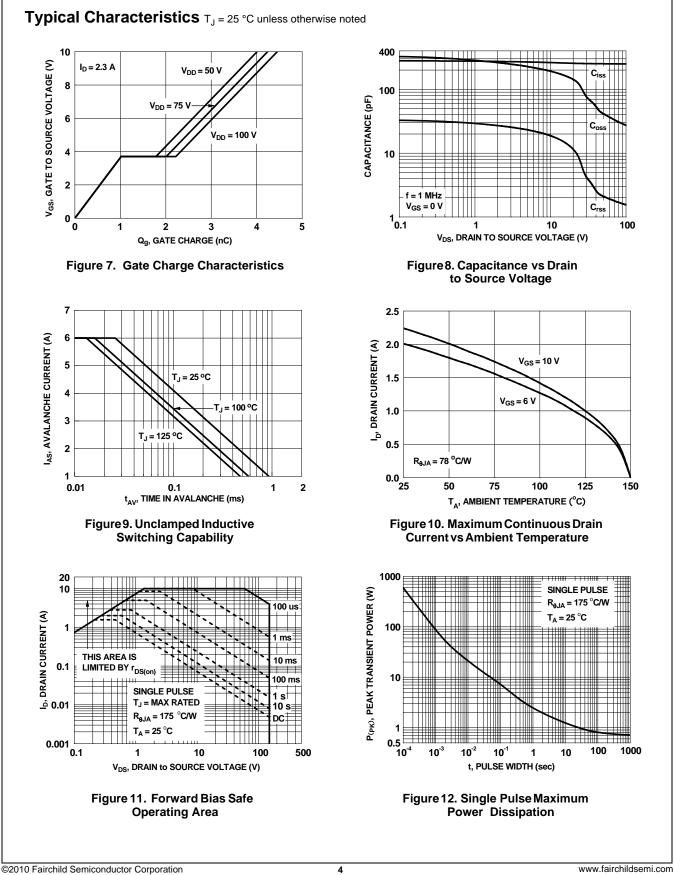
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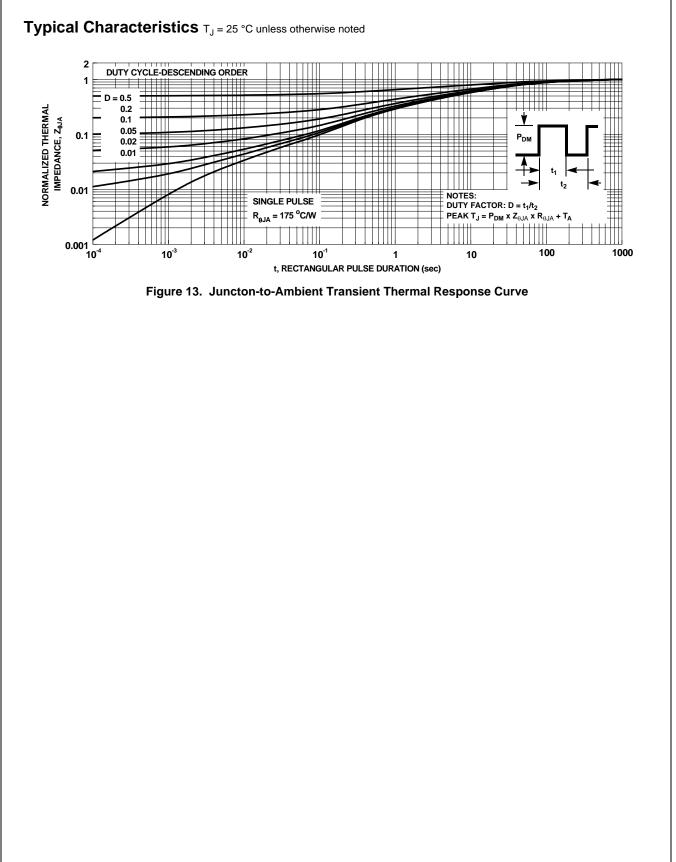
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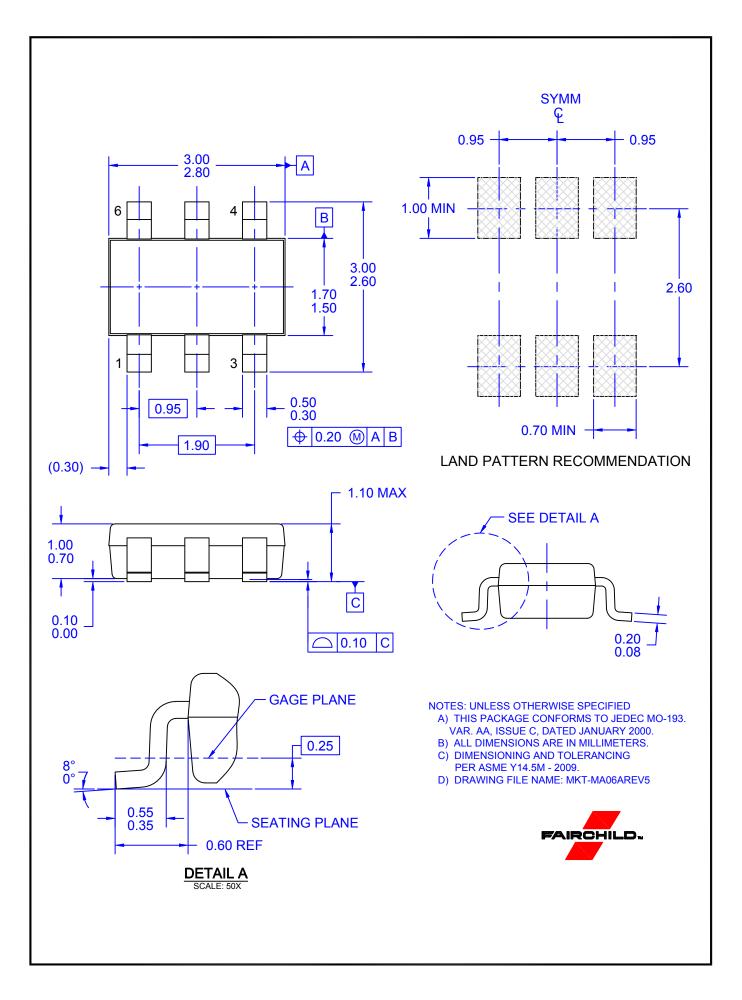


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